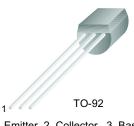


- This device designed for use as general purpose amplifier and switches requiring collector currents to 300mA.
- · Sourced from Process 10.
- See PN100 for characteristics.



1. Emitter 2. Collector 3. Base

NPN Epitaxial Silicon Transistor

Absolute Maximum Ratings* T_a=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	30	V
V _{CBO}	Collector-Base Voltage	50	V
V _{EBO}	Emitter-Base Voltage	5.0	V
I _C	Collector Current - Continuous	500	mA
T _J , T _{ST}	Operating and Storage Junction Temperature Range	-55 ~ +150	°C

* These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

These ratings are based on a maximum junction temperature of 150 degrees C.
These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

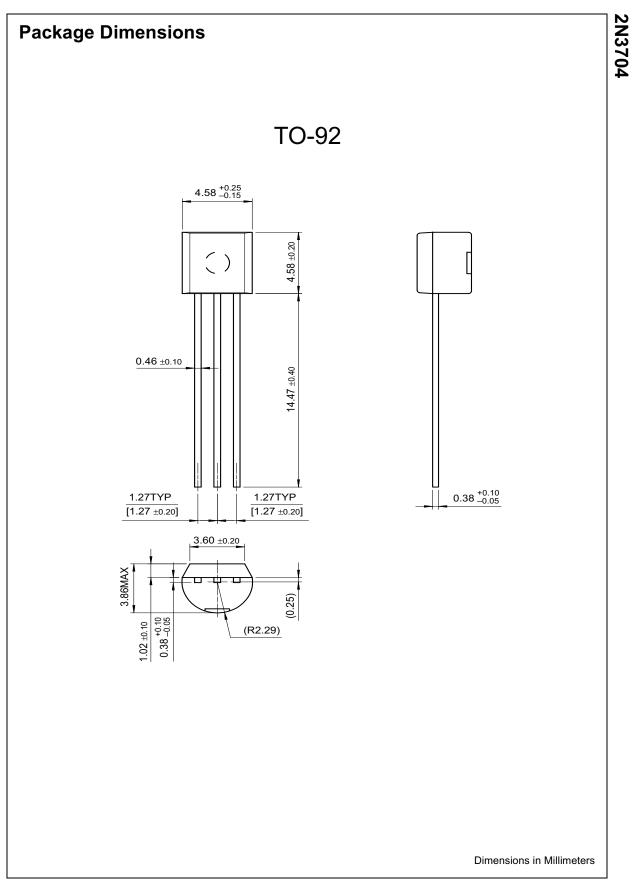
Electrical Characteristics T_a=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Characteristics						
BV _{(BR)CEO}	Collector-Emitter Breakdown Voltage	I _C = 10mA, I _B = 0	30			V
BV _{(BR)CBO}	Collector-Base Breakdown Voltage	I _C = 100μA, I _E = 0	50			V
BV _{(BR)EBO}	Emitter-Base Breakdown Voltage	I _E = 100μA, I _C = 0	5.0			V
I _{CBO}	Collector Cut-off Current	V _{CB} = 20V, I _E = 0			100	nA
I _{EBO}	Emitter Cut-off Current	V _{EB} = 3.0V, I _C = 0			100	nA
On Characteristics *						
h _{FE}	DC Current Gain	V _{CE} = 5.0V, I _C = 50mA	100		300	
V _{CE} (sat)	Collector-Emitter Saturation Voltage	I _C = 100mA, I _B = 5.0mA	0.5		1.0	V
V _{BE} (on)	Collector-Emitter On Voltage	V _{CE} = 2.0V, I _C = 100mA			0.6	V
Small Signal Characteristics						
C _{ob}	Current Gain Bandwidth Product	V _{CB} = 10V, f = 1.0MHz			12	pF
f _T	Output Capacitance	I _C = 50mA, V _{CE} = 2.0V	100			MHz
Pulse Test: Puls	$se \le 300 \mu s$, Duty Cycle $\le 2.0\%$	•	•	•	•	•

 \leq 300µs, Duty Cycle \leq 2.0%

Thermal Characteristics $T_A=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Max.	Units
PD	Total Device Dissipation	625	mW
	Derate above 25°C	5.0	mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	83.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	°C/W



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Bottomless™	FAST®	LittleFET™	Power247™	SuperSOT™-3
CoolFET™	FASTr™	MicroFET™	PowerTrench [®]	SuperSOT™-6
CROSSVOLT™	FRFET™	MicroPak™	QFET™	SuperSOT™-8
DOME™	GlobalOptoisolator™	MICROWIRE™	QS™	SyncFET™
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E ² CMOS [™]	HiSeC™	MSXPro™	Quiet Series™	TruTranslation™
EnSigna™	l²C™	OCX™	RapidConfigure™	UHC™
		OCXPro™	RapidConnect™	UltraFET®
Across the board	. Around the world.™	OPTOLOGIC [®]	SILENT SWITCHER®	VCX™
The Power Franc	hise™	OPTOPLANAR™	SMART START™	

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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
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